



Outline

- **Integrated EBSD & EDS for Phase Identification**
- **EBSD Based Phase Differentiation**
- **Integrated EBSD & EDS Phase Differentiation**
- **Component Analysis**

EDAX TSL

Phase identification

EDS Spectrum

EBSD

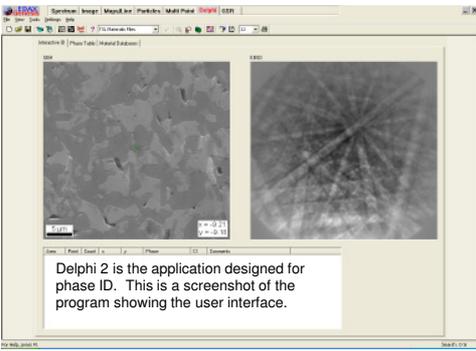
Fe_2TiO_4

Candidate Phases

Fe_2TiO_4	Cubic	a=11.297
Fe-Ti-O	Cubic	a=11.31
$Fe_4(TiO_4)_3$	Tetragonal	a=9.3, c=9.5
$FeTiO_3$	Trigonal	a=5.0884, c=14.093
Fe_2TiO_4	Cubic	a=8.5352
$Fe_3Ti_3O_{10}$	Orthorhombic	a=7.789, b=10.008, c=9.74162
$FeTiO_3$	Orthorhombic	a=5.026, b=5.174, c=7.245
$Fe_2Ti_3O_9$	Hexagonal	a=2.8667, b=4.5985

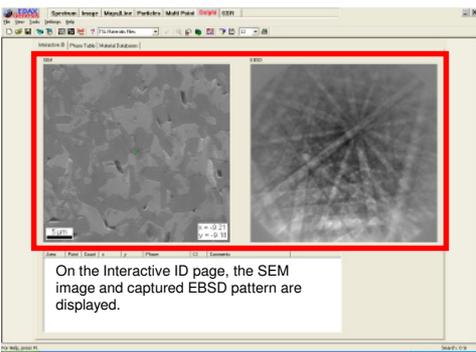
EDAX TSL

Delphi 2



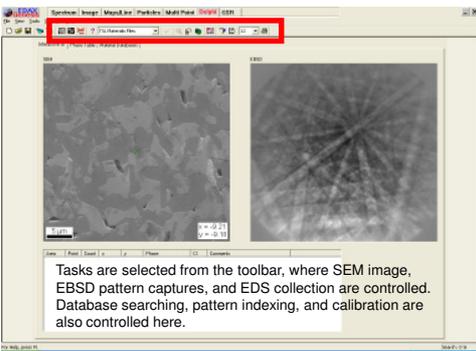
EDAX™

Delphi 2



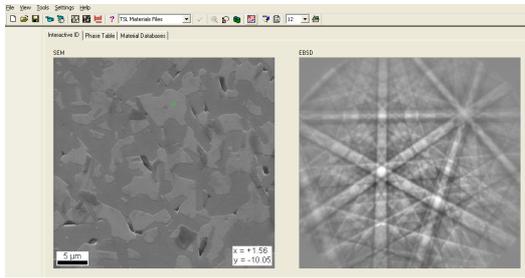
EDAX™

Delphi 2



EDAX™

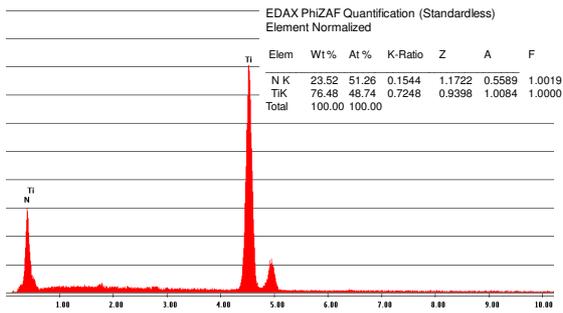
Delphi 2



An analysis location is selected in the SEM image, and an EBSD pattern collected from that position.

EDAX™

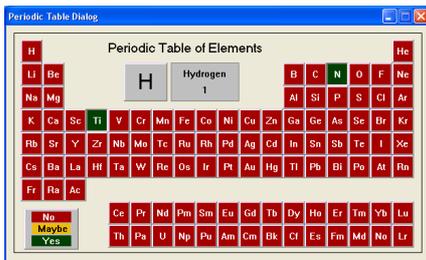
Example 1



An EDS spectrum is also collected. Here Ti and N were identified as being present. Quant analysis indicates 51% N and 49% Ti

EDAX™

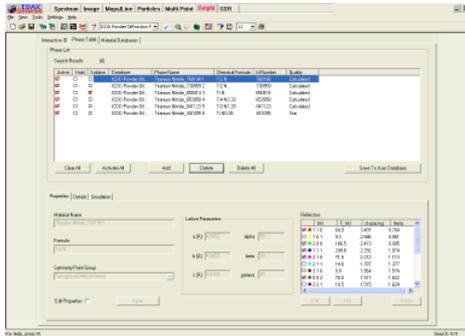
Example 1



The periodic table is used to specify which elements to search for in the different databases. A Yes/No/Maybe search for each element is possible. Here Ti and N are considered to be present.

EDAX™

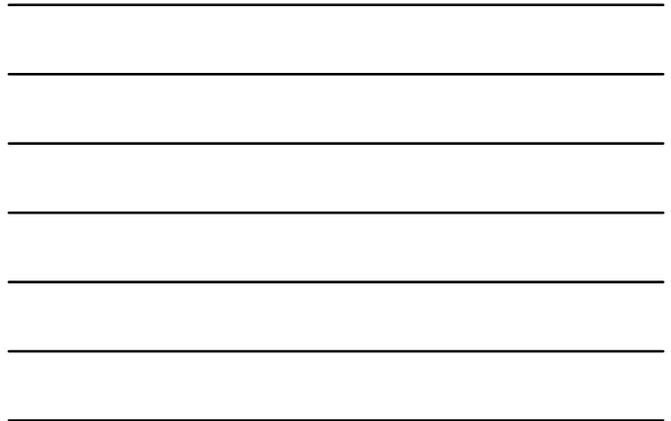
Example 1



After duplication filtering, 6 candidates with this elemental chemistry are found. The results are shown on the Phase Table page.



10



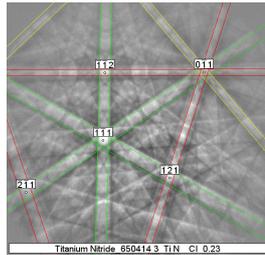
Example 1

The phase differentiation procedure is then used with these 6 candidate phases.

The TiN phase (PDF#6504143) initially has the highest Rank Factor, as well as the highest Cl value. It also has the lowest fit value.

However, it has only the 2nd highest number of votes (20 vs. 30).

Visual inspection of the solution shows while the displayed bands match, only some of the observed bands are accounted for.



Phase	Votes	Fit (%)	Cl	Rank-Fact
<input checked="" type="checkbox"/> Titanium Nitride_6504143	20	0.60	0.226	3.00
<input type="checkbox"/> Titanium Nitride_6539584	5	1.17	0.012	1.07
<input type="checkbox"/> Titanium Nitride_7309592	30	2.42	0.060	0.76
<input type="checkbox"/> Titanium Nitride_4410956	4	2.05	0.000	0.45
<input type="checkbox"/> Titanium Nitride_7601981	4	3.51	0.000	0.34
<input type="checkbox"/> Titanium Nitride_8411235	4	5.56	0.000	0.21



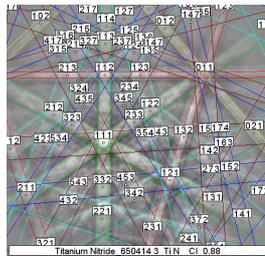
11



Example 1

Reflector	hkl	F _{hkl}	d-spacing	theta
<input checked="" type="checkbox"/> 111	111	1775	2.460	1.000
<input checked="" type="checkbox"/> 200	200	3300	2.130	1.195
<input checked="" type="checkbox"/> 220	220	767	1.906	1.634
<input checked="" type="checkbox"/> 311	311	148	1.284	1.916
<input checked="" type="checkbox"/> 331	331	48	0.977	2.519
<input checked="" type="checkbox"/> 420	420	99	0.953	2.584
<input checked="" type="checkbox"/> 422	422	81	0.870	2.831
<input checked="" type="checkbox"/> 511	44	44	0.820	3.003

Reflector	hkl	F _{hkl}	d-spacing	theta
<input checked="" type="checkbox"/> 111	111	1775	2.460	1.000
<input checked="" type="checkbox"/> 200	200	3300	2.130	1.195
<input checked="" type="checkbox"/> 220	220	767	1.906	1.634
<input checked="" type="checkbox"/> 311	311	148	1.284	1.916
<input checked="" type="checkbox"/> 331	331	48	0.977	2.519
<input checked="" type="checkbox"/> 420	420	99	0.953	2.584
<input checked="" type="checkbox"/> 422	422	81	0.870	2.831
<input checked="" type="checkbox"/> 511	44	44	0.820	3.003



Phase	Votes	Fit (%)	Cl	Rank-Fact
<input checked="" type="checkbox"/> Titanium Nitride_6504143	82	0.59	0.881	3.00
<input type="checkbox"/> Titanium Nitride_6539584	5	1.17	0.012	1.02
<input type="checkbox"/> Titanium Nitride_7309592	30	2.42	0.060	0.56
<input type="checkbox"/> Titanium Nitride_4410956	4	2.05	0.000	0.45
<input type="checkbox"/> Titanium Nitride_7601981	4	3.51	0.000	0.34
<input type="checkbox"/> Titanium Nitride_8411235	4	5.56	0.000	0.21

A better match is found by manually inspecting bands and activating reflectors initially deactivated due to intensity.

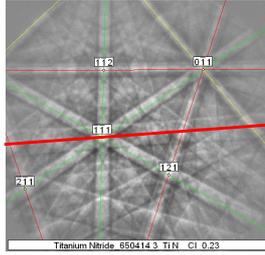
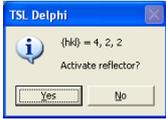


12



Example 1

Reflector	hkl	F _{hkl}	dspacing	theta
<input checked="" type="checkbox"/>	111	177.5	2.460	1.000
<input checked="" type="checkbox"/>	200	333.0	2.130	1.195
<input checked="" type="checkbox"/>	220	76.7	1.506	1.634
<input checked="" type="checkbox"/>	311	14.8	1.204	1.916
<input checked="" type="checkbox"/>	331	4.8	0.977	2.519
<input checked="" type="checkbox"/>	420	9.9	0.953	2.584
<input checked="" type="checkbox"/>	422	8.1	0.670	2.831
<input checked="" type="checkbox"/>	511	4.4	0.620	3.003

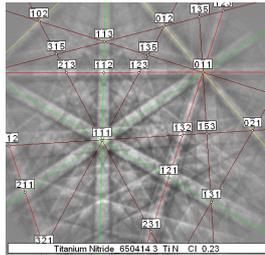


13

EDAX™

Example 1

When manually activating or adding reflectors, equivalent planes are also used. This can be used as a test to see if the correct structure is being used.



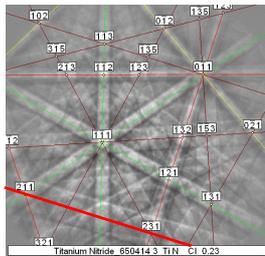
14

EDAX™

Example 1



hkl	F _{hkl}	dspacing	theta	
<input checked="" type="checkbox"/>	111	177.5	2.460	1.000
<input checked="" type="checkbox"/>	200	333.0	2.130	1.195
<input checked="" type="checkbox"/>	220	76.7	1.506	1.634
<input checked="" type="checkbox"/>	311	14.8	1.204	1.916
<input checked="" type="checkbox"/>	331	4.8	0.977	2.519
<input checked="" type="checkbox"/>	420	9.9	0.953	2.584
<input checked="" type="checkbox"/>	422	8.1	0.670	2.831
<input checked="" type="checkbox"/>	511	4.4	0.620	3.003



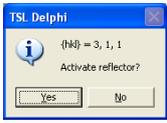
Determines that this band is the {420} band. Checks the database file to see if this {420} band is present.

Option to Activate this Band into the Indexing routine

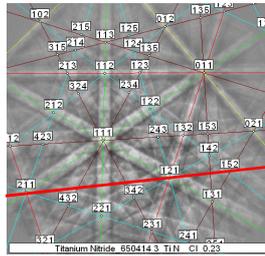
15

EDAX™

Example 1



	hkl	F_hkl	dspacing	theta
✓	1 1 1	177.5	2.460	1.000
✓	2 0 0	333.0	2.130	1.195
✓	2 2 0	78.7	1.536	1.634
✓	3 1 1	14.8	1.284	1.916
✓	3 3 1	4.0	0.977	2.519
✓	4 2 0	89	0.953	2.584
✓	4 2 2	61	0.870	2.931
✓	5 1 1	4.4	0.820	3.003



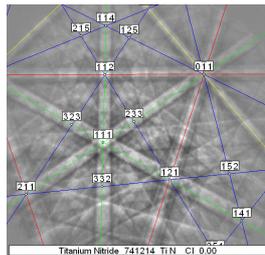
16

EDAX™

Example 1

	hkl	F_hkl	dspacing	theta
✓	1 1 1	174.5	2.540	0.969
✓	2 0 0	333.0	2.200	1.119
✓	2 2 0	77.3	1.556	1.582
✓	3 1 1	14.8	1.327	1.855

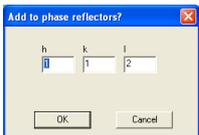
For some database files, the list of possible reflectors is incomplete.



17

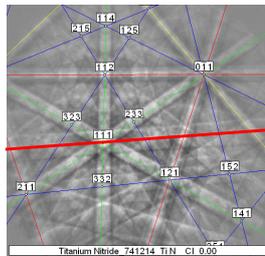
EDAX™

Example 1



Instead of activating expected reflectors, manual inspection will add reflectors to the material file.

In this example, a low index (h+k+l=low number) plane is identified, which is what is expected for EBSD.

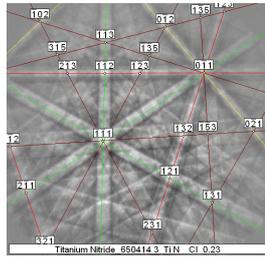


18

EDAX™

Example 1

Just as when activating reflector, when adding reflectors, if the symmetrically equivalent bands also match bands in the pattern then this is a good confirmation of the correct phase identification.



19

EDAX™

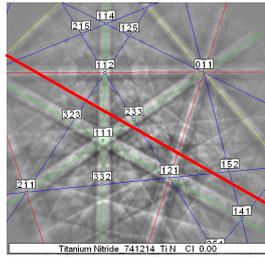
Example 1

Add to phase reflectors?

h	k	l
10	4	11

OK Cancel

For an arbitrary line however, a high index plane is identified. Care and judgment must be used when adding a reflector.



20

EDAX™

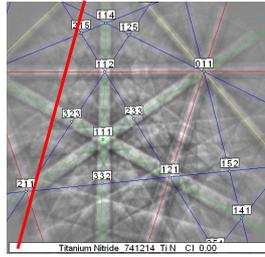
Example 1

Add to phase reflectors?

h	k	l
10	20	1

OK Cancel

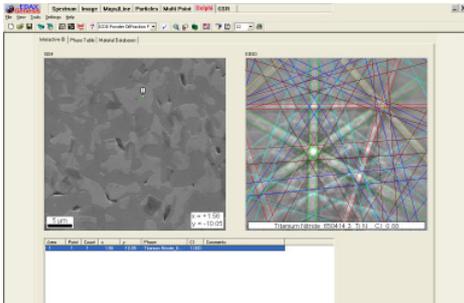
Also watch for rounding errors when manually drawing lines. The plane should be a [1-20] plane.



21

EDAX™

Example 1

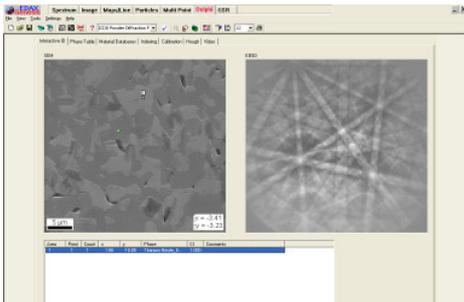


The phase solution is then recorded for this analysis point. The phase, with reflector adjustment, can then be saved to a user database for OIM mapping and additional phase ID.

22

EDAX™

Example 1



The darker "phase" is then selected in the SEM image, and a pattern obtained. EDS analysis indicated Ti and B are present.

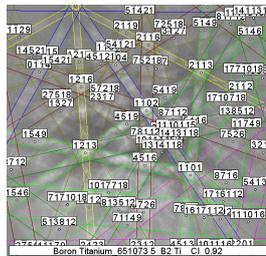
23

EDAX™

Example 1

Phase	Votes	Fa (%)	Cl	dSpace Fx	Rank	Fx
□ Boon Fka...	84	0.20	0.917	1.00	3.00	
□ Boon Fka...	35	1.22	0.280	1.00	0.56	
□ Ti Arsen B...	4	1.98	0.024	1.00	0.23	
□ Boon Fka...	4	2.25	0.024	1.00	0.20	
□ Boon Fka...	2	2.38	0.012	1.00	0.19	
□ Boon Fka...	6	3.00	0.012	1.00	0.15	
□ Ti Arsen B...	4	2.86	0.000	1.00	0.14	
□ Boon Fka...	3	3.19	0.000	1.00	0.13	
□ Boon Fka...	4	3.60	0.000	1.00	0.11	
□ Boon Fka...	1	3.76	0.000	1.00	0.11	
□ Ti Arsen B...	1	5.63	0.000	1.00	0.07	
□ Boon Fka...	4	10.24	0.012	1.00	0.05	

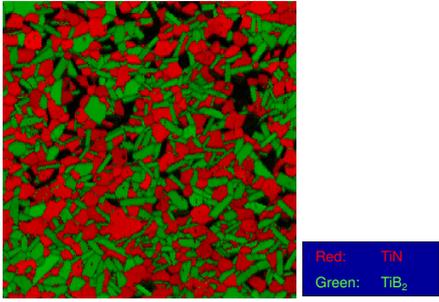
The second phase is identified as TiB₂ following the same procedure.



24

EDAX™

Example 1

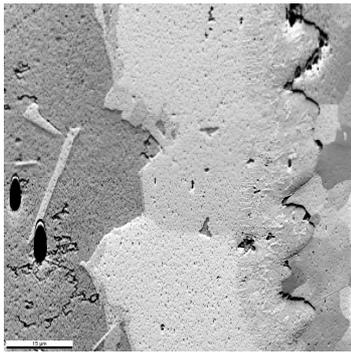


With these material files, it is then possible to obtain a multi-phase OIM map.

25



Example: phase identification



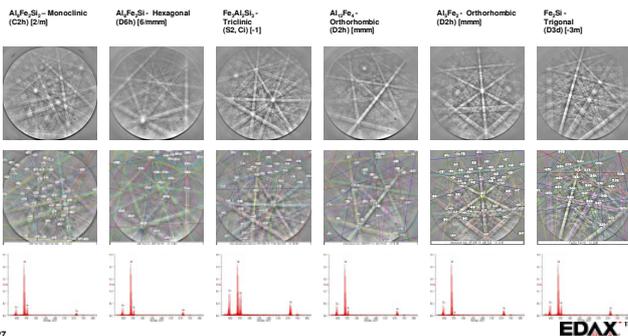
- FSD image of a Al – Fe weld interface.
- At the interface Si was added to facilitate the welding process.
- A large number of phases could be identified on the BSE and FSD (left) images.
- All the phases contain Al, Fe, and / or Si in different quantities and may be part of continuous solid-solution series.

26



Phase identification: Al-Fe (Si) welding interface

- The elements are identified for each phase
- This chemistry is used to search a database of candidate phases (e.g. ICDD database)
- The candidates are matched against the pattern using dedicated Phase ID software, Delphi.

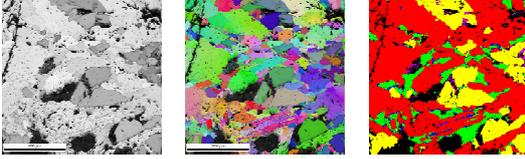


27



Common issues with EBSD on multiphase materials

- Large variation in EBSD pattern quality due to different polishing properties.



- Need to index each pattern with all possible phases and then select the best solution. This is slow and may produce errors.
- Phases may have the same crystal structure and cannot be differentiated from each other by EBSD (e.g. Ni vs. Cu).

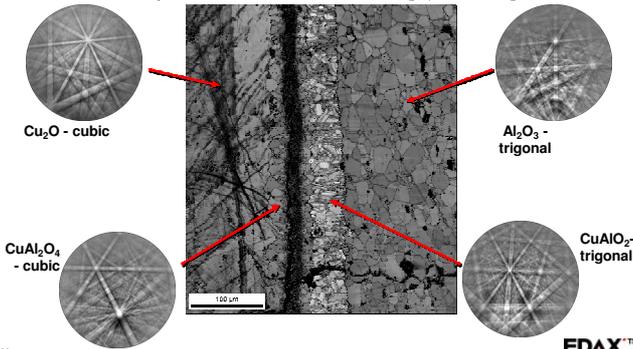
31

EDAX™

Multi-Symmetry Sample

Copper oxide – Aluminium oxide reaction couple

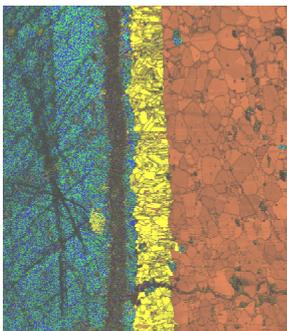
Two phases formed at the interface: CuAl_2O_4 and CuAlO_2



32

EDAX™

Conventional phase differentiation



Both trigonal phases, Al_2O_3 (orange) and CuAlO_2 (yellow) are successfully identified

The cubic phases Cu_2O (blue) and CuAl_2O_4 (green) could not be distinguished

Gray Scale Map Type: Image Quality
0.261432 (0.261432)

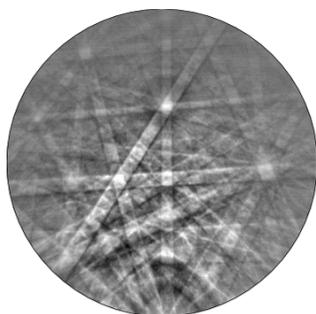
Phase	Total Fraction	Partition Fraction
Al_2O_3	0.417	0.422
CuAl_2O_4	0.140	0.142
CuAlO_2	0.120	0.121
Cu_2O	0.312	0.315

33

EDAX™

Scanning multiphase materials – phase 1

1. Obtain a pattern

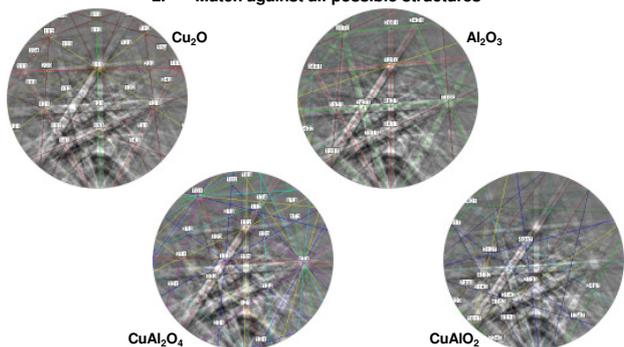


34

EDAX™

Scanning multiphase materials – phase 1

2. Match against all possible structures



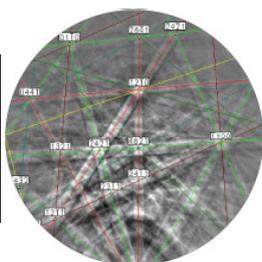
35

EDAX™

Scanning multiphase materials – phase 1

3. Select the best fit solution

phase	votes	fit (°)	confidence index	rank
CuO ₂	6	2.10	0.000	0.48
Al ₂ O ₃	80	0.86	0.500	3.00
CuAlO ₂	12	2.10	0.017	0.59
CuAl ₂ O ₄	8	2.11	0.008	0.52

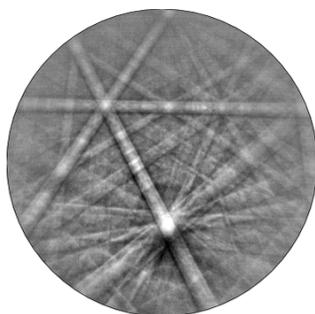


36

EDAX™

Scanning multiphase materials – phase 2

1. Obtain a pattern

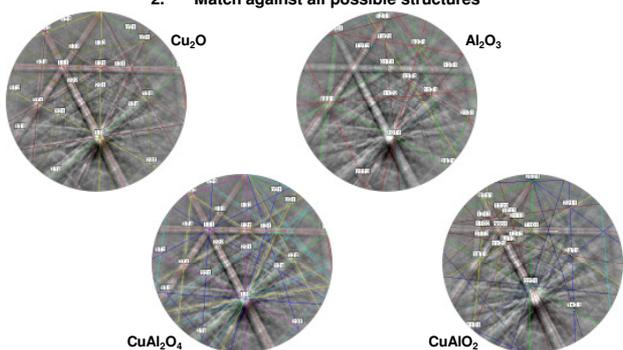


37

EDAX™

Scanning multiphase materials – phase 2

2. Match against all possible structures



38

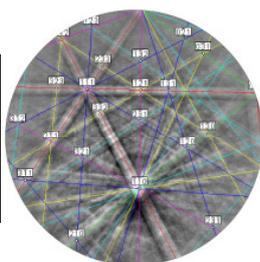
EDAX™

Scanning multiphase materials – phase 2

3. Select the best fit solution

Both phases are cubic

phase	votes	fit (°)	confidence index	rank
CuO ₂	56	0.46	0.821	3.00
Al ₂ O ₃	10	1.78	0.018	0.46
CuAlO ₂	13	1.69	0.107	0.63
CuAl ₂ O ₄	56	0.46	0.821	3.00



39

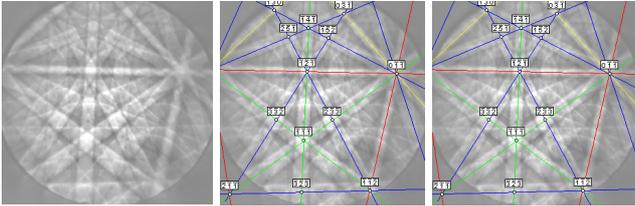
EDAX™

Phase differentiation

Nickel Pattern

Indexed as Nickel

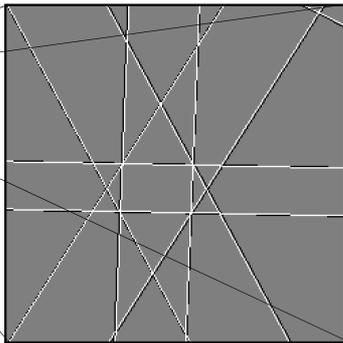
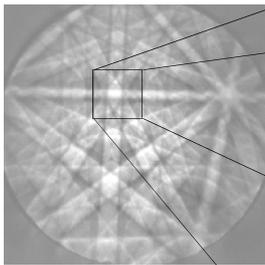
Indexed as Copper



40

EDAX™

Phase differentiation – band widths



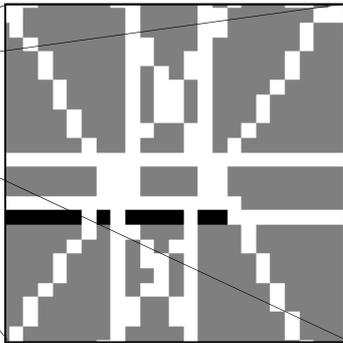
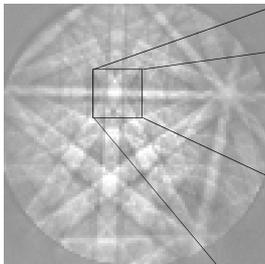
— Nickel ($a = 3.52\text{\AA}$)
— Copper ($a = 3.61\text{\AA}$)

1024 x 1024 Image

41

EDAX™

Phase differentiation – band widths



— Nickel ($a = 3.52\text{\AA}$)
— Copper ($a = 3.61\text{\AA}$)

96 x 96 Image

42

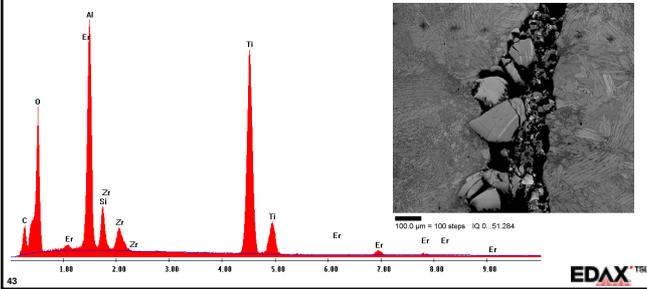
EDAX™

Sample

Titanium-aluminum sample with inclusions.

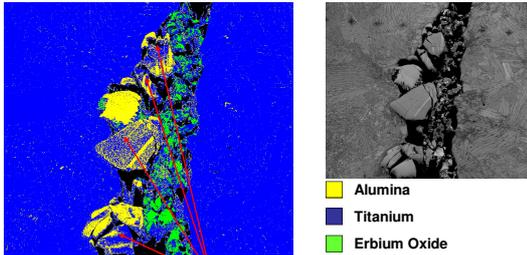
The EDS spectrum showed that titanium, aluminum, oxygen, zirconium and erbium were present in the material.

We knew a-priori that the two main phases were a hexagonal Ti phase and trigonal Alumina. We also identified an Erbium Oxide phase and two Zirconium Oxides.



Conventional phase differentiation

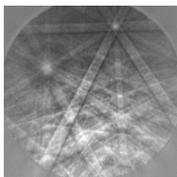
It was obvious from the phase map, that the software had a difficult time differentiating the Titanium and Alumina phases reliably. We tried modifying some of the indexing parameters but with about 870,000 data points these off-line iterations were fairly time consuming (about 3 hours each). Therefore, it was difficult to optimize the settings to improve the results.



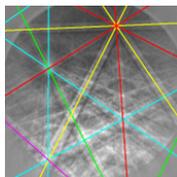
Should all be yellow!

Conventional phase differentiation

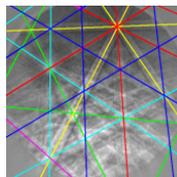
Pattern from Alumina



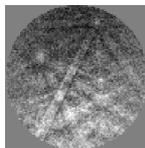
Indexed as Alumina



Indexed as Titanium

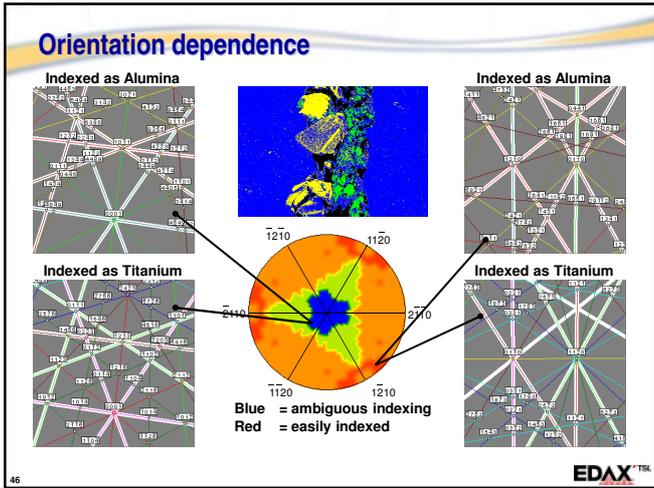


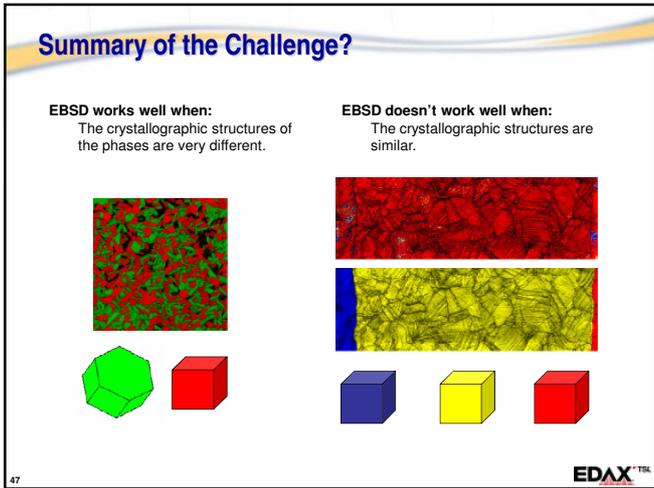
Real full speed scan patterns are much weaker than the beautiful high resolution pattern above.

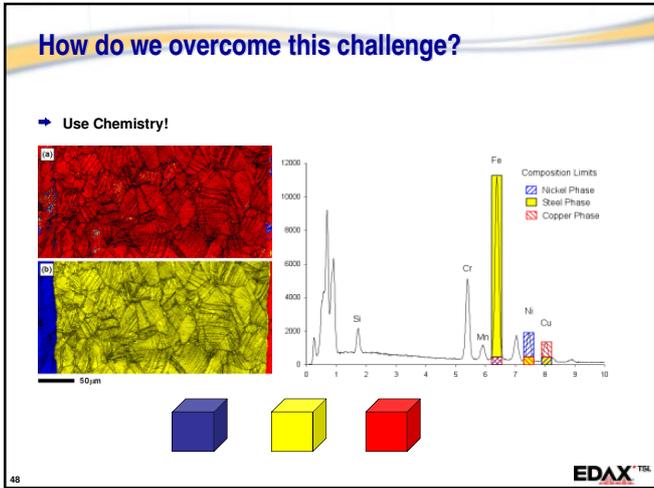


8x8 binning & then compressed to 96x96









Outline

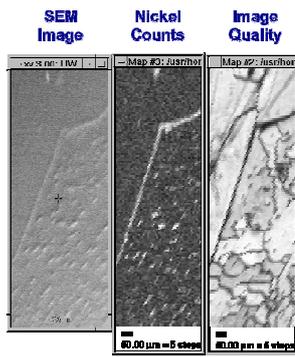
- Integrated EBSD & EDS for Phase **Identification**
- EBSD Based Phase Differentiation
- **Integrated EBSD & EDS Phase Differentiation**
- **Component Analysis**

49

EDAX™

Combined EBSD + EDS

- Simultaneous EDS and EBSD mapping have been available for 14 years.



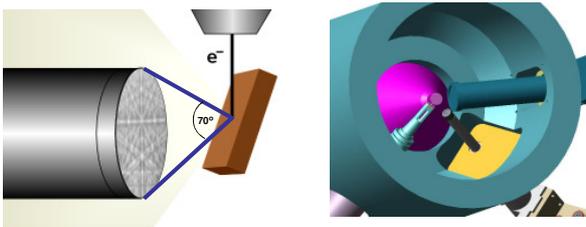
S. I. Wright (1997) Unpublished work at the University of Wisconsin-Madison. Presented at Microscopy and Microanalysis, 1997 Cleveland, Ohio.

50

EDAX™

Detector considerations

- For good simultaneous EDS - EBSD analysis, the sample surface has to be within the line of sight of both detectors.
- The EBSD detector must see a proper solid angle.
- There should be no detector shadowing.



51

EDAX™

Phase differentiation using simultaneous EDS and EBSD

- ➔ Analysis area is scanned and at each point the relevant pattern parameters are stored together with the EDS region-of-interest counts.
- ➔ Positions of phases are determined using X-ray maps.
- ➔ During off-line indexing, the recorded chemistry determines which phase / crystal structure file is used for indexing of each point
- ➔ Each pattern is indexed by only one phase

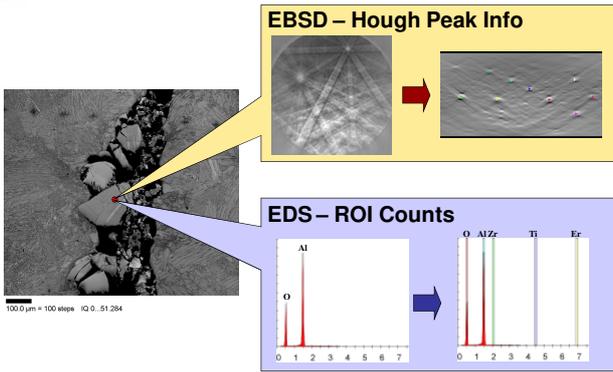
ChI scan – Chemistry assisted Indexing

M. M. Nowell and S. I. Wright (2004). "Phase differentiation via combined EBSD and XEDS." *Journal of Microscopy* 213: 296-305

EDAX™

52

Data collected

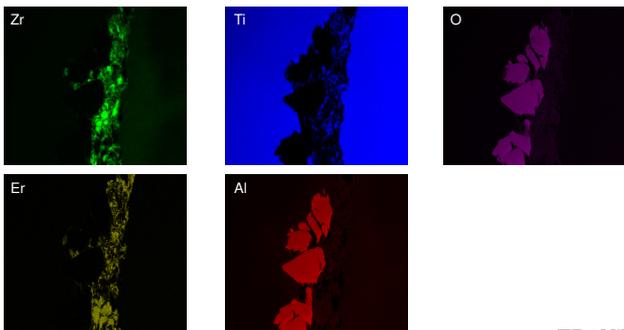


EDAX™

53

Elemental maps

We were able to construct element maps from the EDS data collected simultaneously. This aided us in locating and identifying other phases. We were able to identify and index two more phases: a monoclinic ZrO₂ phase and a tetragonal ZrO₂ phase.



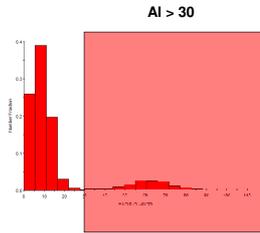
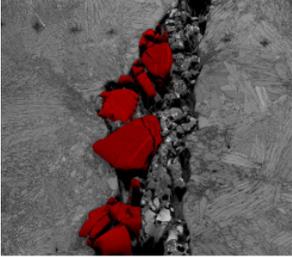
EDAX™

54

Chemical filtering (Al_2O_3)

All of the red grains will be indexed as Alumina

Al elemental map



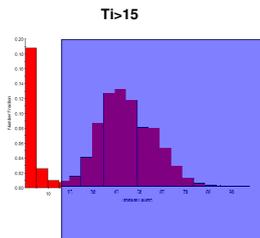
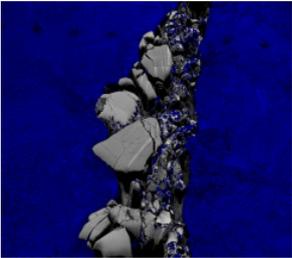
55

EDAX™ TSL

Chemical filtering (Ti)

Everything highlighted in blue will be indexed as titanium

Ti elemental map



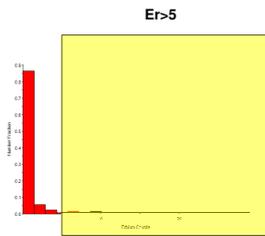
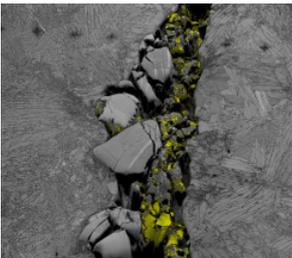
56

EDAX™ TSL

Chemical filtering (Er_2O_3)

Everything highlighted in yellow will be indexed as Erbium Oxide.

Er elemental map



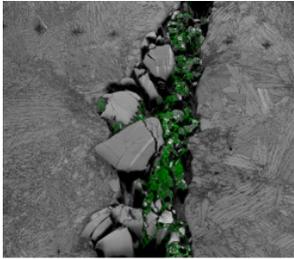
57

EDAX™ TSL

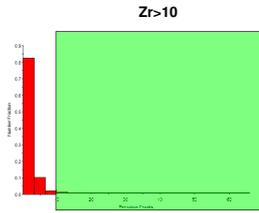
Chemical filtering (ZrO₂)

Everything in green will be indexed as either tetragonal Zirconium Oxide or monoclinic Zirconium Oxide. EBSD will be used to differentiate between the two.

Zr elemental map



100.0 μm = 100 steps IQ 3.253...209.584, EDS [Zirconium] 10...66

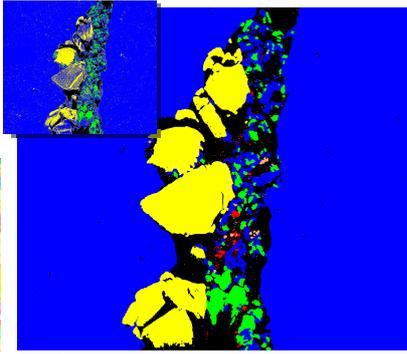
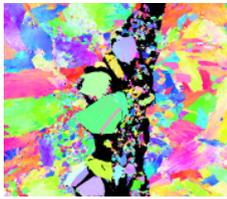


58

EDAX™

Chemical assisted indexing – CHI scan

By filtering the data based on chemistry as part of the phase differentiation process we get much better results as shown here. In addition it speeds up the indexing process quite a bit. It took 20 minutes to rescan this data set using all 5 phases with the chemical filter turned on and 3 hours without the filter turned on.

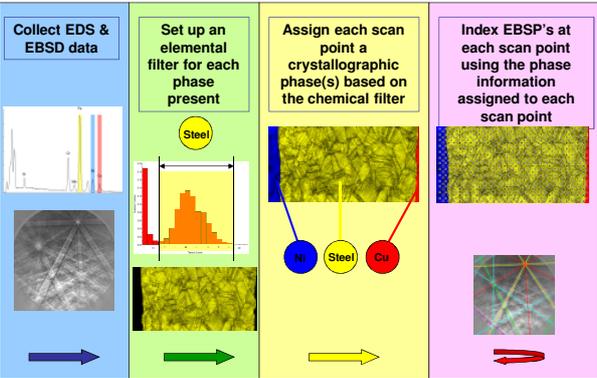


100.0 μm = 100 steps Phase

59

EDAX™

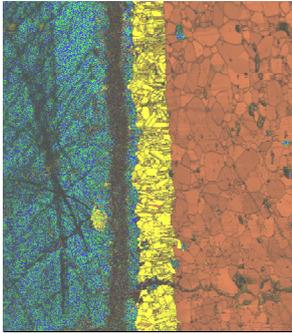
Flowchart



60

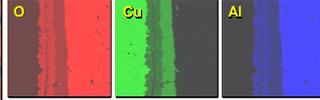
EDAX™

ChI scan phase differentiation – Example 2



Both trigonal phases, Al_2O_3 (orange) and CuAlO_2 (yellow) are successfully identified

The cubic phases Cu_2O (blue) and CuAl_2O_4 (green) could not be distinguished with EBSD alone, but are clear in the X-Ray maps (below)

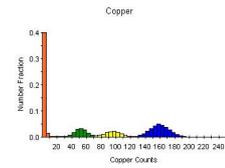
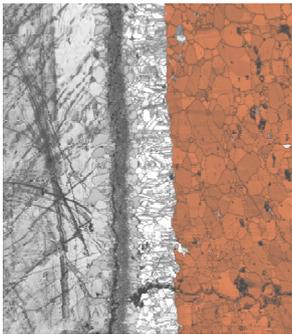


Phase:
 Al_2O_3
 CuAl_2O_4
 CuAlO_2
 Cu_2O

EDAX™

61

Chemical filtering

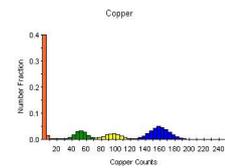
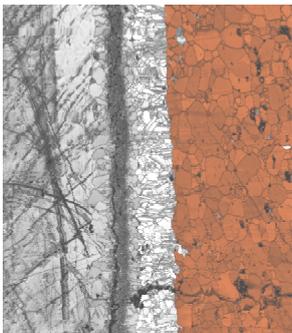


Cu_2O
 CuAlO_2
 CuAl_2O_4
 Al_2O_3

EDAX™

62

Chemical filtering



These phase definitions can now be used to select the proper crystal structure for each pixel in the scan, and distinguish crystallographically similar phases.

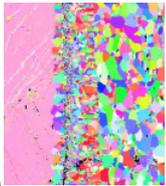
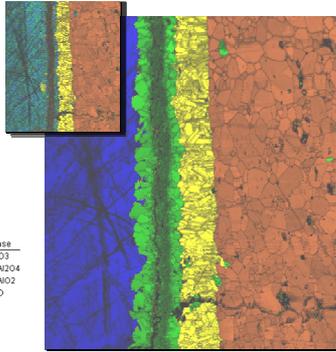
EDAX™

63

Chi-Scan results

By filtering the data based on chemistry as part of the phase differentiation process it is now possible to differentiate between the cubic phases and the microstructural properties of all phases may be investigated.

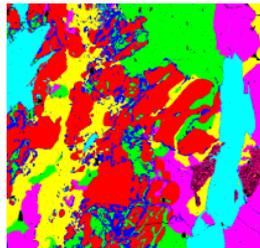
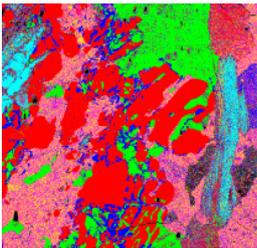
In addition, indexing speed is greatly improved from 1 hour (conventional scanning) to 10 minutes when rescanning this dataset using all 4 phases with the chemical filter turned on.



64

EDAX™

Example - mineral



Phases	Chemical Limits (EDS Counts)
Nickeline	Ni>10, As>45, S<30
Pyrrhotite	Ni<10, S>20, As<10, Cu<10, Fe>40
Chalcopyrite	S>20, Ni<10, As<10, Cu>10, Fe>15
Cobalite	As>10, S>15
Pentlandite	S>20, Fe>15, Cu<10, Ni>10
Biotite	K>10
Carbon	C>20

65

EDAX™

Outline

- Integrated EBSD & EDS for Phase **Identification**
- EBSD Based Phase Differentiation
- Integrated EBSD & EDS Phase **Differentiation**
- **Component Analysis**

66

EDAX™

Automated phase recognition (PCA)

Issues with phase selection based on chemistry:

- Variation in EDS intensity over the scan area
 - 1- Because of the high-tilts required for EBSD, there is often a change in the EDS signal with WD
 - 2- Beam instabilities may cause variations in countrates during long scans



• Difference in spatial resolution of EDS and EBSD

The spatial resolutions of the two techniques are approximately 50 nm and 1 micron for EBSD and EDS respectively. Thus, there will be some "smearing" at the boundaries where the EBSD must be used exclusively for the phase differentiation.

These issues can be minimised with Automated Phase Recognition

67

EDAX™

Phase cluster analysis

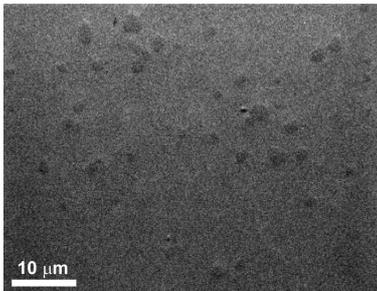
A method of statistical analysis of chemistry data:

- ➔ Groups pixels based on similarity in the chemistry (EDS ROI counts).
- ➔ Allows the user to automatically find phases in the recorded data without prior knowledge.
- ➔ PCA ChI scan bridges the gap between the spatial resolutions of EBSD and EDS.
 - Grains down to 200 nm can now successfully be defined.

68

EDAX™

Silicon and Chromium Carbides in Cobalt Matrix



SE image

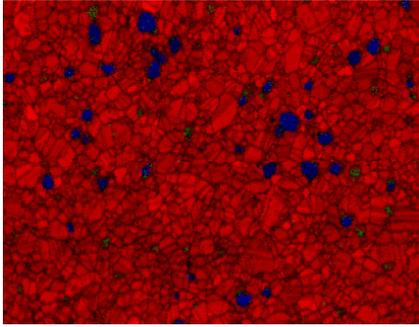
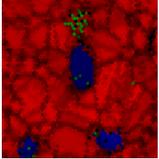
69

EDAX™

Results from the manually set limits

- Cobalt
- Chromium Carbide
- Silicon Carbide

Difficult to find good sets of limits because of limited resolution.

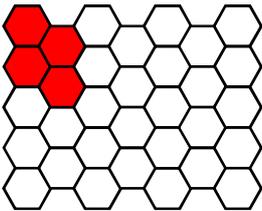


20 μm

EDAX™

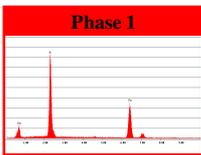
73

Phase cluster analysis



Step 1 - The spectra from the first 4 pixel block of measurement points are taken together and are assumed to be from a single phase.

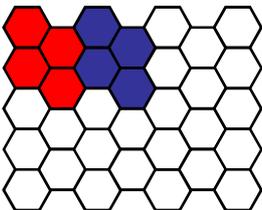
The EDS signal from these pixels is defined as reference phase 1.



EDAX™

74

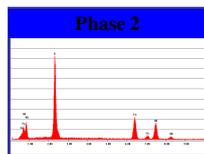
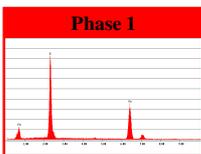
Phase cluster analysis



Step 2-The average spectrum from the second 4x4 block is compared to the first component. (Using a "contingency coefficient" based on the sum of squared differences calculated from normalized spectra)

$$\chi^2 = \sum_{i=1}^N \frac{(S_i - s_i)^2}{S_i} \quad C = \frac{\chi^2}{\chi^2 + N}$$

The "spectra" are normalized before calculating the χ^2 values. N is the number of channels in the EDS spectra. S_i and s_i are the number of counts in the i^{th} channel of spectra S and s. C is the contingency coefficient.

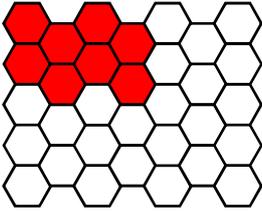


EDAX™

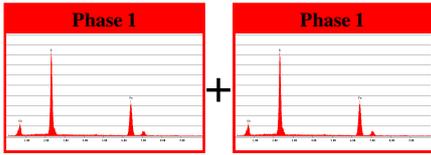
75

Reference: Numerical recipes in C: The art of scientific computing. E. H. Press, S. A. Teukolsky, W. T. Vetterling and B. P. Flannery. Cambridge University Press: Cambridge (1992).

Phase cluster analysis



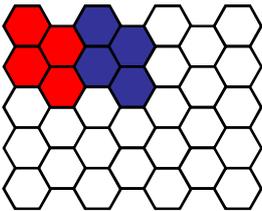
Step 3 - Step 3-If the second block matches the first component within a given tolerance of the contingency coefficient, this second spectrum is added to the first component.



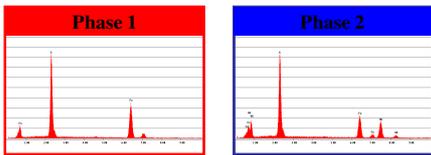
76

EDAX™

Phase cluster analysis



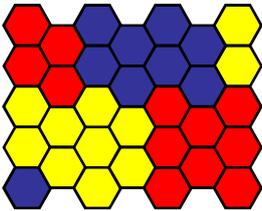
Step 4 - If the second block does not match the reference chemistry, it then defines a reference phase 2.



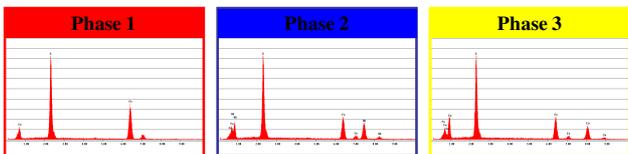
77

EDAX™

Phase cluster analysis



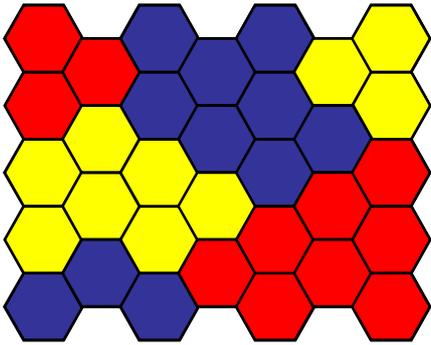
Step 5 - This comparative process is continued until each 4 pixel block has been matched to a phase.



78

EDAX™

Phase cluster analysis

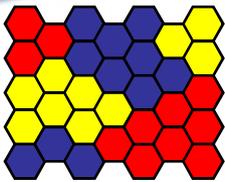


Step 6 –
When all reference
phases are defined,
the chemistry of each
individual pixel is
compared with and
matched to one of the
determined phases.

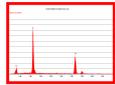
79

EDAX™

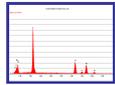
Phase cluster analysis



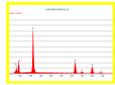
Step 7 - Candidate phases are
assigned to each chemical
component.



Phase A



Phase B
Phase C



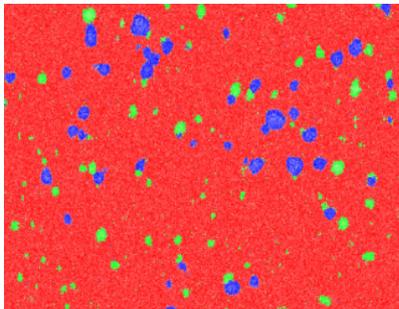
Phase D

80

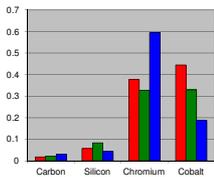
EDAX™

Component analysis

The component analysis
found three components.
With the following
"spectra". The variation in
the hue shows the
difference of the individual
pixel from the average for
the component.



Component 1 → Cobalt
Component 2 → Chromium Carbide
Component 3 → Silicon Carbide



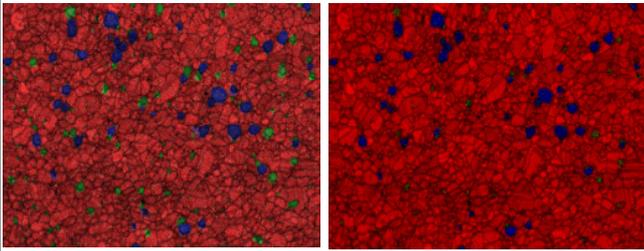
81

EDAX™

Component analysis - comparison

Component Analysis

Manual Limit Setting

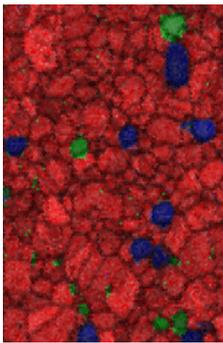


■ Cobalt ■ Chromium Carbide ■ Silicon Carbide

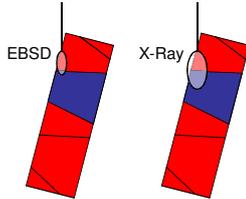
82

EDAX™

Comparison of PCA with Manual Limits



Note the "bleed" below some of the blue and green grains. This is a resolution difference effect. The bottom of the map corresponds to the top of sample.

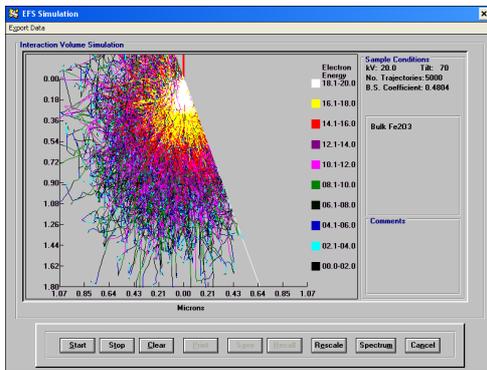


Gray scale in the map is for EBSD, colors are for X-Ray

83

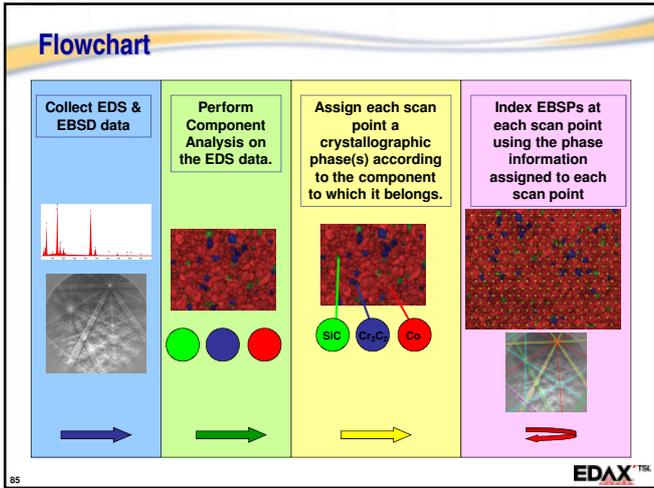
EDAX™

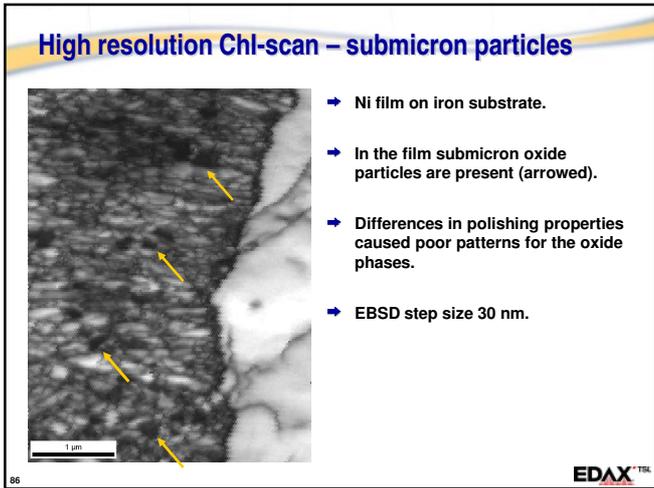
EDS interaction Volume

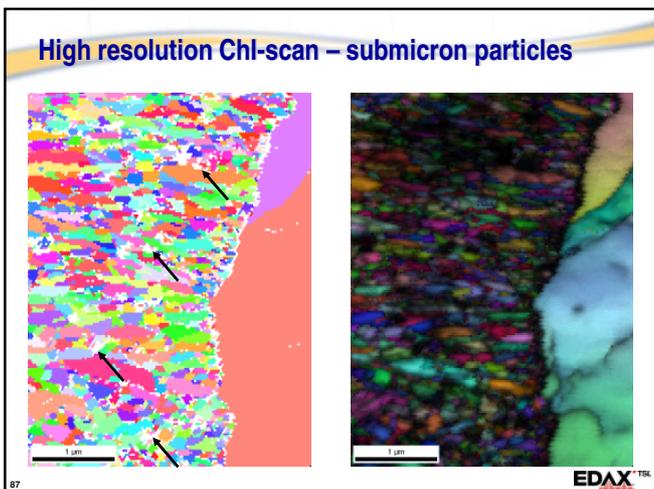


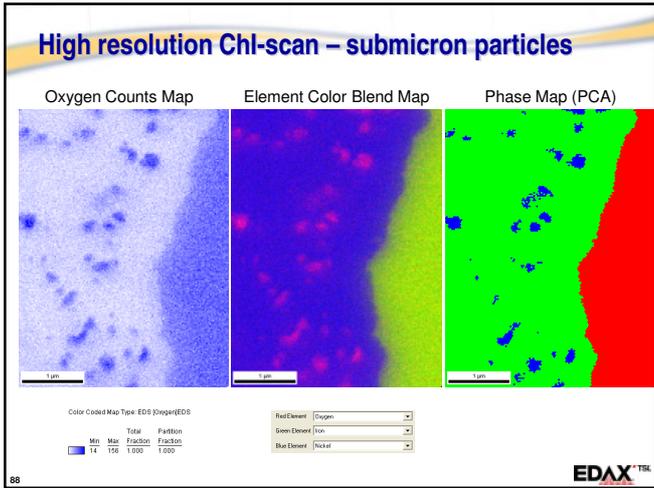
84

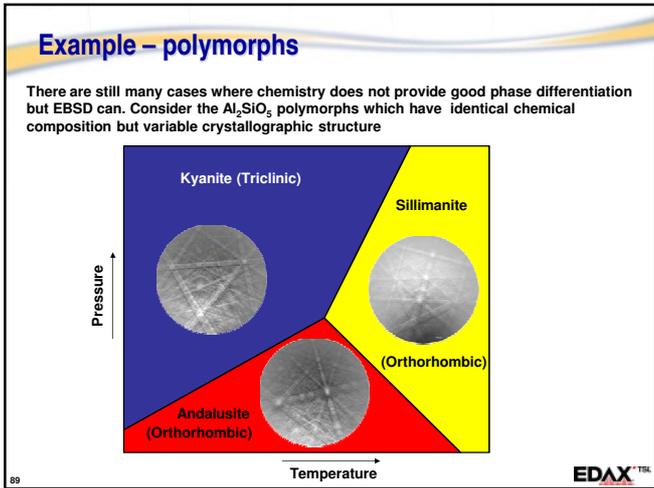
EDAX™

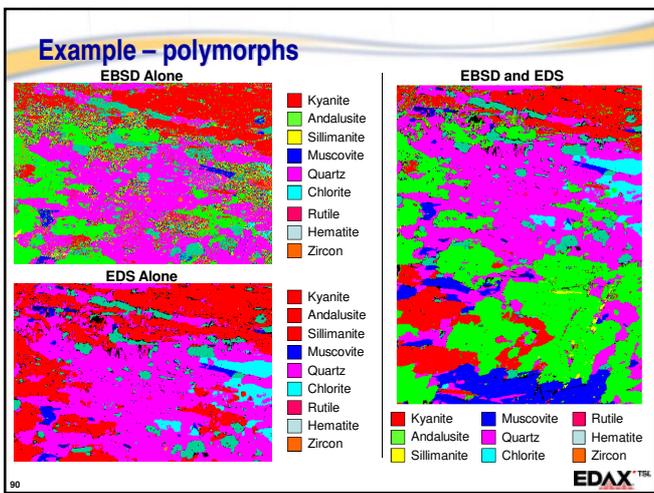












Conclusions

Multi-phase indexing with (PCA) ChI-scan enables:

- Distinction of phases with similar crystal structure
- Distinction of phases with similar chemistry
- Greatly improved indexing accuracy
- Allows fast scanning of polyphase materials regardless of the number of phases present
- Minimises effects of different spatial resolutions of EDS and EBSD and variation in EDS intensities
- Typical ChI-scan collection speeds are between 10 and 100 points per second.
(100 to 10 msec EDS dwell time)

81

EDAX™
